

PATENT NUMBER and
ISSUE DATE

U.S. UTILITY Patent Application

APPL NUM	FILING DATE	CLASS	SUBCLASS	GAU	EXAMINER
10086718	03/04/2002	324	76.19	2858	Vincent Q. Nguyen

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**CONTINUING DATA VERIFIED: None/V.N

** FOREIGN APPLICATIONS VERIFIED: Yes/V.N
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PG-PUB	DO NOT PUBLISH <input type="checkbox"/>	RESCIND <input type="checkbox"/>	
Foreign priority claimed 35 USC 119 conditions met Verified and Acknowledged Examiner's initials	<input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input checked="" type="checkbox"/> yes <input type="checkbox"/> no	ATTORNEY DOCKET NO H-1031	
TITLE : Modulation semiconductor integrated circuit device and testing method for oscillation circuit U.S. DEPT. OF COMM/PAT. & TM-PTO-436L(Rev. 12-94)			

NOTICE OF ALLOWANCE MAILED		CLAIMS ALLOWED	
ISSUE FEE		Assistant Examiner	
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TERMINAL DISCLAIMER		Primary Examiner	
		PREPARED FOR ISSUE	
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